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PATENT  
Docket No. 81790.0119  
Former Docket No. 005702-20068

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Continuation Application of:

Art Unit: 2784

Tomomi MOMOHARA

Examiner: H. Nguyen

Serial No: Not yet assigned 09/511.620

Filed: February 23, 2000

For: SEMICONDUCTOR INTEGRATED  
CIRCUIT DEVICE AND METHOD OF  
TESTING THE SAME

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Dear Sir:

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George M. Cooper (Reg. No. 20,201)  
Douglas R. Hanscom (Reg. No. 26,600); and associates  
Jennifer P. Yancy (Reg. No. 47,003),  
Kenneth M. Jones (Reg. No. 48,203),  
Anne Murphy and Karen Robertson,

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located at JONES, TULLAR & COOPER, P.C., Suite 1002, 2001 Jefferson Davis  
Highway, Arlington, Virginia 22202, to inspect and make copies of the above-  
referenced patent application. The undersigned is an attorney of record.

Respectfully submitted,

HOGAN & HARTSON L.L.P.

By:

*Brian D. Martin*

Brian D. Martin

Registration No. 47,771

Attorney for Applicant

Date: September 12, 2001

500 South Grand Avenue, Suite 1900  
Los Angeles, California 90071  
Phone: 213-337-6700  
Fax: 213-337-6701